Boost Converter Stage in APM16 Series for Multiphase and Semi-Bridgeless PFC with SiC Diodes

FAM65CR51ADZ1, FAM65CR51ADZ2

Features

- Integrated SIP or DIP Boost Converter Stage Power Module for On-board Charger (OBC) in EV or PHEV
- 5 kV/1 sec Electrically Isolated Substrate for Easy Assembly
- Creepage and Clearance per IEC60664-1, IEC 60950-1
- Compact Design for Low Total Module Resistance
- Module Serialization for Full Traceability
- Lead Free, RoHS and UL94V-0 Compliant
- Automotive Qualified per AEC Q101 and AQG324 Guidelines
- Improved Performance with SiC Diodes

Applications

• PFC Stage of an On-board Charger in PHEV or EV

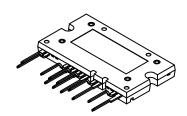
Benefits

- Enable Design of Small, Efficient and Reliable System for Reduced Vehicle Fuel Consumption and CO₂ Emission
- Simplified Assembly, Optimized Layout, High Level of Integration, and Improved Thermal Performance

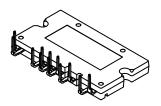


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APMCD-A16 12 LEAD CASE MODGG



APMCD-B16 12 LEAD CASE MODGK

MARKING DIAGRAM

XXXXXXXXXX ZZZ ATYWW NNNNNNN

XXXX = Specific Device Code

ZZZ = Lot ID

AT = Assembly & Test Location

Y = Year W = Work Week NNN = Serial Number

ORDERING INFORMATION

See detailed ordering, marking and shipping information on page 2 of this data sheet.

ORDERING INFORMATION

| Part Number | Package | Lead Forming | DBC Material | Pb-Free and RoHS Compliant | Operating Temperature (T _A) | Packing Method |
|---------------|-----------|--------------|--------------|-------------------------------|--|-------------------|
| FAM65CR51ADZ1 | APM16-CDA | Y-Shape | Al2O3 | Yes | −40°C ~ 125°C | Tube |
| FAM65CR51ADZ2 | APM16-CDB | L-Shape | Al2O3 | Yes | −40°C ~ 125°C | Tube |

Pin Configuration and Description

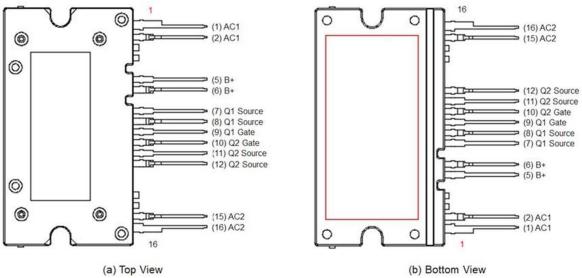


Figure 1. Pin Configuration

Table 1. PIN DESCRIPTION

| Pin Number | Pin Name | Pin Description |
|------------|-----------|-------------------------------|
| 1, 2 | AC1 | Phase 1 Leg of the PFC Bridge |
| 3 | NC | Not Connected |
| 4 | NC | Not Connected |
| 5, 6 | B+ | Positive Battery Terminal |
| 7, 8 | Q1 Source | Source Terminal of Q1 |
| 9 | Q1 Gate | Gate Terminal of Q1 |
| 10 | Q2 Gate | Gate Terminal of Q2 |
| 11, 12 | Q2 Source | Source Terminal of Q2 |
| 13 | NC | Not Connected |
| 14 | NC | Not Connected |
| 15, 16 | AC2 | Phase 2 Leg of the PFC Bridge |

INTERNAL EQUIVALENT CIRCUIT

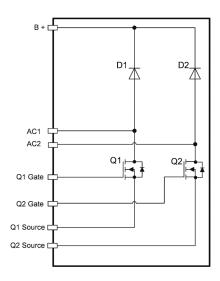


Figure 2. Internal Block Diagram

Table 2. ABSOLUTE MAXIMUM RATINGS OF MOSFET (T_J = 25°C, Unless Otherwise Specified)

| | , 3 | • , | |
|-------------------------|--|-------------|------|
| Symbol | Parameter | Max | Unit |
| V _{DS} (Q1~Q2) | Drain-to-Source Voltage | 650 | V |
| V _{GS} (Q1~Q2) | Gate-to-Source Voltage | ±20 | V |
| I _D (Q1~Q2) | Drain Current Continuous (T _C = 25°C, V _{GS} = 10 V) (Note 1) | 41 | А |
| | Drain Current Continuous (T _C = 100°C, V _{GS} = 10 V) (Note 1) | 25 | Α |
| E _{AS} (Q1~Q2) | Single Pulse Avalanche Energy (Note 2) | 623 | mJ |
| P_{D} | Power Dissipation (Note 1) | 189 | W |
| T_J | Maximum Junction Temperature | -55 to +150 | °C |
| T _C | Maximum Case Temperature | -40 to +125 | °C |
| T _{STG} | Storage Temperature | -40 to +125 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

DBC Substrate

0.63 mm Al2O3 alumina with 0.3 mm copper on both sides. DBC substrate is NOT nickel plated.

Lead Frame

OFC copper alloy, 0.50 mm thick. Plated with 8 µm to 25.4 µm thick Matte Tin

Flammability Information

All materials present in the power module meet UL flammability rating class 94V-0.

Compliance to RoHS Directives

The power module is 100% lead free and RoHS compliant 2000/53/C directive.

Solder

Solder used is a lead free SnAgCu alloy.

Solder presents high risk to melt at temperature beyond 210°C. Base of the leads, at the interface with the package body, should not be exposed to more than 200°C during mounting on the PCB or during welding to prevent the re-melting of the solder joints.

^{1.} Maximum continuous current and power, without switching losses, to reach $T_J = 150^{\circ}\text{C}$ respectively at $T_C = 25^{\circ}\text{C}$ and $T_C = 100^{\circ}\text{C}$; defined by design based on MOSFET R_{DS(ON)} and R_{θ JC} and not subject to production test 2. Starting T_J = 25°C, I_{AS} = 6.5 A, R_G = 25 Ω

Table 3. ELECTRICAL SPECIFICATIONS OF MOSFET (T_J = 25°C, Unless Otherwise Specified)

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|------------------------|-----------------------------------|--|------|------|------|-------|
| BV _{DSS} | Drain-to-Source Breakdown Voltage | I _D = 1 mA, V _{GS} = 0 V | 650 | - | - | V |
| V _{GS(th)} | Gate-to-Source Threshold Voltage | $V_{GS} = V_{DS}$, $I_D = 3.3 \text{ mA}$ | 3.0 | - | 5.0 | V |
| R _{DS(ON)} Q1 | Q1 Low Side MOSFET | V _{GS} = 10 V, I _D = 20 A | - | 44 | 51 | m $Ω$ |
| R _{DS(ON)} Q2 | Q2 Low Side MOSFET | | - | 44 | 51 | mΩ |
| R _{DS(ON)} Q1 | Q1 Low Side MOSFET | V _{GS} = 10 V, I _D = 20 A, T _J = 125°C (Note 3) | - | 79 | - | mΩ |
| R _{DS(ON)} Q2 | Q2 Low Side MOSFET | | - | 79 | - | mΩ |
| 9FS | Forward Transconductance | V _{DS} = 20 V, I _D = 20 A (Note 3) | - | 30 | - | S |
| I _{GSS} | Gate-to-Source Leakage Current | V _{GS} = ±20 V, V _{DS} = 0 V | -100 | - | +100 | nA |
| I _{DSS} | Drain-to-Source Leakage Current | V _{DS} = 650 V, V _{GS} = 0 V | - | - | 10 | μΑ |
| DYNAMIC CHA | ARACTERISTICS (Note 3) | | | | | |
| C _{iss} | Input Capacitance | V _{DS} = 400 V | - | 4864 | - | pF |
| C _{oss} | Output Capacitance | V _{GS} = 0 V f = 1 MHz | - | 109 | - | pF |
| C _{rss} | Reverse Transfer Capacitance | I = I IVIDZ | - | 16 | - | pF |
| C _{oss(eff)} | Effective Output Capacitance | V _{DS} = 0 to 520 V V _{GS} = 0 V | - | 652 | - | pF |
| R_g | Gate Resistance | f = 1 MHz | - | 2 | _ | Ω |
| Q _{g(tot)} | Total Gate Charge | V _{DS} = 380 V | - | 123 | - | nC |
| Q _{gs} | Gate-to-Source Gate Charge | I _D = 20 A V _{GS} = 0 to 10 V | - | 37.5 | - | nC |
| Q _{gd} | Gate-to-Drain "Miller" Charge | VGS = 0 to 10 V | | 49 | - | nC |
| SWITCHING C | HARACTERISTICS (Note 3) | | | • | • | |
| t _{on} | Turn-on Time | V _{DS} = 400 V | _ | 87 | _ | ns |
| t _{d(on)} | Turn-on Delay Time | I _D = 20 A | - | 47 | _ | ns |
| t _r | Turn-on Rise Time | V_{GS} = 10 V R_{G} = 4.7 Ohm | - | 43 | _ | ns |
| t _{off} | Turn-off Time | G | - | 146 | _ | ns |
| t _{d(off)} | Turn-off Delay Time | | - | 118 | - | ns |
| t _f | Turn-off Fall Time | | - | 29 | - | ns |
| BODY DIODE | CHARACTERISTICS | | | - | - | - |
| V_{SD} | Source-to-Drain Diode Voltage | I _{SD} = 20 A, V _{GS} = 0 V | - | 0.95 | - | V |
| T _{rr} | Reverse Recovery Time | V _{DS} = 520 V, I _D = 20 A, | - | 133 | - | ns |
| Q _{rr} | Reverse Recovery Charge | d _I /d _t = 100 A/μs (Note 3) | - | 669 | - | nC |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

3. Defined by design, not subject to production test

Table 4. ABSOLUTE MAXIMUM RATINGS OF THE BOOST DIODE (T_J = 25°C, Unless Otherwise Specified)

| Symbol | Parameter | Rating | Unit |
|--------------------|---|-------------|------|
| V_{RRM} | Peak Repetitive Reverse Voltage (Note 4) | 650 | V |
| E _{AS} | Avalanche Energy (17 A, 1 mH) | 144 | mJ |
| l _F | Continuous Rectified Forward Current, T _C < 148°C | 30 | Α |
| I _{F,MAX} | Non-Repetitive Forward Surge Current, T _C = 25°C, 10 μs | 1100 | Α |
| I _{F,MAX} | Non-Repetitive Forward Surge Current, T _C = 150°C, 10 μs | 1000 | Α |
| I _{FSM} | Non-Repetitive Peak Surge Current (Sine Half Wave, Tp = 8.3 ms) | 110 | Α |
| P_{D} | Power Dissipation (T _C = 25°C) | 65 | W |
| TJ | Maximum Junction Temperature | -55 to +175 | °C |
| T _C | Maximum Case Temperature | -40 to +125 | °C |
| T _{STG} | Storage Temperature | -40 to +125 | °C |

^{4.} V_{RRM} and I_F value referenced to TO220-2L Auto Qualified Package Device FFSP3065B_F085

Table 5. ELECTRICAL SPECIFICATIONS OF THE BOOST DIODE (T_J = 25°C, Unless Otherwise Specified)

| Symbol | Parameter | Test Cond | itions | Min | Тур | Max | Unit |
|----------------|-------------------------------|-------------------------|------------------------|-----|------|-----|------|
| V_{DC} | DC Blocking Voltage | I _R = 200 μA | T _C = 25°C | 650 | - | _ | V |
| V _F | Instantaneous Forward Voltage | I _F = 30 A | T _C = 25°C | - | 1.38 | 1.7 | V |
| | | | T _C = 125°C | - | 1.6 | 2.0 | V |
| | | | T _C = 175°C | - | 1.72 | 2.4 | V |
| I _R | Instantaneous Reverse Current | V _R = 650 V | T _C = 25°C | - | 0.5 | 40 | μΑ |
| | | | T _C = 125°C | - | 1.0 | 80 | μΑ |
| | | | T _C = 175°C | - | 2.0 | 160 | μΑ |
| Q_{C} | Total Capacitive Charge | V _R = 400 V | T _C = 25°C | - | 43 | _ | nC |
| С | Total Capacitance | V _R = 1 V | f = 100 kHz | | 1280 | | pF |
| | | V _R = 200 V | f = 100 kHz | | 139 | | |
| | | V _R = 400 V | f = 100 kHz | | 108 | | |

Table 6. THERMAL RESISTANCE

| | Parameters | | | Max | Unit |
|------------------------------------|--|---|------|------|------|
| R _{θJC} (per MOSFET chip) | Q1,Q2 Thermal Resistance Junction-to-Case (Note 5) | - | 0.47 | 0.66 | °C/W |
| R _{θJS} (per MOSFET chip) | Q1,Q2 Thermal Resistance Junction-to-Sink (Note 6) | - | 0.95 | _ | °C/W |
| R _{θJC} (per DIODE chip) | D1,D2 Thermal Resistance Junction-to-Case (Note 5) | - | 1.78 | 2.3 | °C/W |
| R _{θJS} (per DIODE chip) | D1,D2 Thermal Resistance Junction-to-Sink (Note 6) | - | 3.10 | Ī | °C/W |

^{5.} Test method compliant with MIL STD 883-1012.1, from case temperature under the chip to case temperature measured below the package at the chip center, Cosmetic oxidation and discoloration on the DBC surface allowed

6. Defined by thermal simulation assuming the module is mounted on a 5 mm Al–360 die casting material with 30 um of 1.8 W/mK thermal

Table 7. ISOLATION (Isolation resistance at tested voltage between the base plate and to control pins or power terminals.)

| Test | Test Conditions | Isolation Resistance | Unit |
|--------------------------------------|--|----------------------|------|
| Leakage @ Isolation Voltage (Hi-Pot) | $V_{AC} = 5 \text{ kV}, 50 \text{ Hz}$ | 100M < | Ω |

interface material

PARAMETER DEFINITIONS

Reference to Table 3: Parameter of MOSFET Electrical Specifications

| BV_{DSS} | Q1, Q2 MOSFET Drain-to-Source Breakdown Voltage |
|---------------------|---|
| | The maximum drain-to-source voltage the MOSFET can endure without the avalanche breakdown of the body- drain P-N junction in off state. |
| | The measurement conditions are to be found in Table 3. |
| | The typ. Temperature behavior is described in Figure 13 |
| V _{GS(th)} | Q1, Q2 MOSFET Gate to Source Threshold Voltage |
| | The gate-to-source voltage measurement is triggered by a threshold ID current given in conditions at Table 4. The typ. Temperature behavior can be found in Figure 10 |
| R _{DS(ON)} | Q1, Q2 MOSFET On Resistance |
| , , | RDS(on) is the total resistance between the source and the drain during the on state. |
| | The measurement conditions are to be found in Table 3. |
| | The typ behavior can be found in Figure 11 and Figure 12 as well as Figure 17 |
| 9 _{FS} | Q1, Q2 MOSFET Forward Transconductance |
| | Transconductance is the gain in the MOSFET, expressed in the Equation below. |
| | It describes the change in drain current by the change in the gate–source bias voltage: $g_{fs} = [\Delta I_{DS} / \Delta V_{GS}]_{VDS}$ |
| I _{GSS} | Q1, Q2 MOSFET Gate-to-Source Leakage Current |
| | The current flowing from Gate to Source at the maximum allowed VGS |
| | The measurement conditions are described in the Table 3. |
| I _{DSS} | Q1, Q2 MOSFET Drain-to-Source Leakage Current |
| | Drain – Source current is measured in off state while providing the maximum allowed drain-to-source voltage and the |
| | gate is shorted to the source. |
| | IDSS has a positive temperature coefficient. |

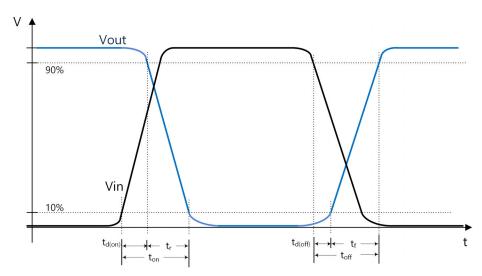


Figure 3. Timing Measurement Variable Definition

Table 8. PARAMETER OF SWITCHING CHARACTERISTICS

| Turn-On Delay (t _{d(on)}) | This is the time needed to charge the input capacitance, Ciss, before the load current ID starts flowing. The measurement conditions are described in the Table 3. For signal definition please check Figure 3 above. |
|---------------------------------------|---|
| Rise Time (t _r) | The rise time is the time to discharge output capacitance, Coss. After that time the MOSFET conducts the given load current ID. The measurement conditions are described in the Table 3. For signal definition please check Figure 3 above. |
| Turn-On Time (ton) | Is the sum of turn-on-delay and rise time |
| Turn-Off Delay (t _{d(off)}) | td(off) is the time to discharge Ciss after the MOSFET is turned off. During this time the load current ID is still flowing The measurement conditions are described in the Table 3. For signal definition please check Figure 3 above. |
| Fall Time (t _f) | The fall time, tf, is the time to charge the output capacitance, Coss. During this time the load current drops down and the voltage VDS rises accordingly. The measurement conditions are described in the Table 3. For signal definition please check Figure 3 above. |
| Turn-Off Time (toff) | Is the sum of turn-off-delay and fall time |

TYPICAL CHARACTERISTICS - MOSFETs

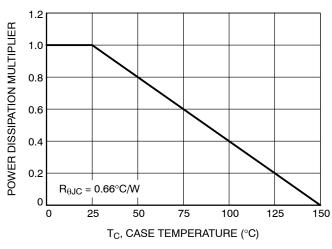


Figure 4. Normalized Power Dissipation vs.

Case Temperature

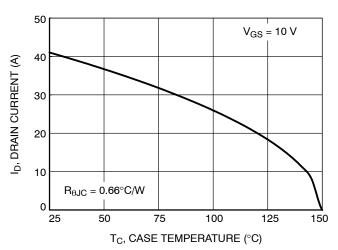


Figure 5. Maximum Continuous I_D vs. Case Temperature

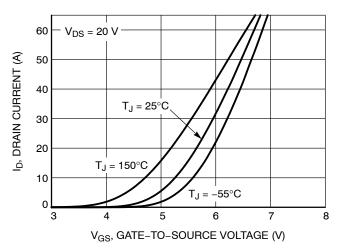


Figure 6. Transfer Characteristics

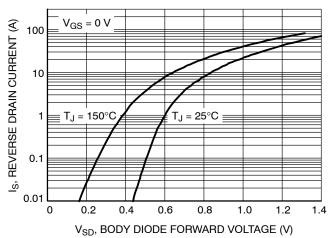


Figure 7. Forward Diode

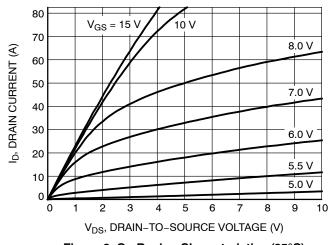


Figure 8. On Region Characteristics (25°C)

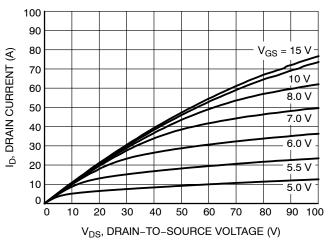
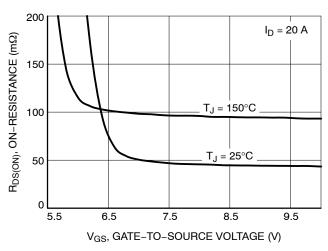


Figure 9. On Region Characteristics (150°C)

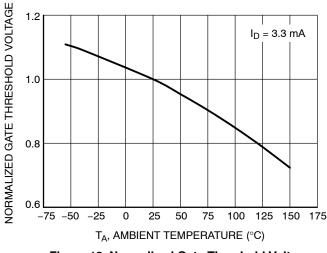
TYPICAL CHARACTERISTICS - MOSFETs



 $I_D = 20 A$ R_{DS(ON)}, NORMALIZED DRAIN-TO-SOURCE ON-RESISTANCE V_{GS} = 10 V 2.0 1.5 1.0 0.5 -75 -50 -25 25 50 75 100 125 150 175 T_J, JUNCTION TEMPERATURE (°C)

Figure 10. On-Resistance vs. Gate-to-Source Voltage

Figure 11. R_{DS(norm)} vs. Junction Temperature



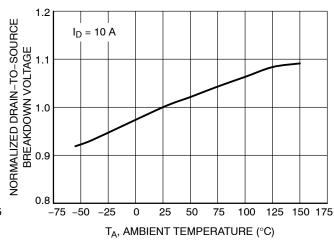
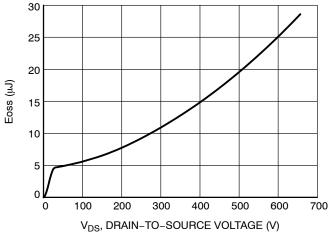


Figure 12. Normalized Gate Threshold Voltage vs. Temperature

Figure 13. Normalized Breakdown Voltage vs.
Temperature



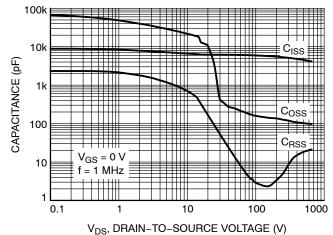


Figure 14. Eoss vs. Drain-to-Source Voltage

Figure 15. Capacitance Variation

TYPICAL CHARACTERISTICS - MOSFETs

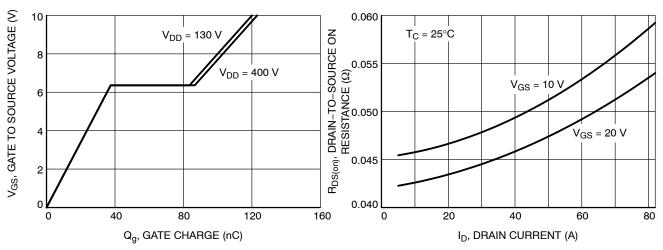


Figure 16. Gate Charge Characteristics

Figure 17. ON-Resistance Variation with Drain Current and Gage Voltage

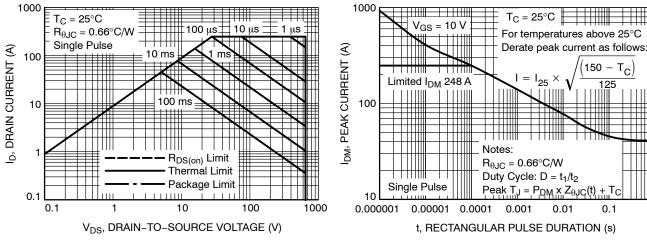


Figure 18. Safe Operating Area

Figure 19. Peak Current Capability

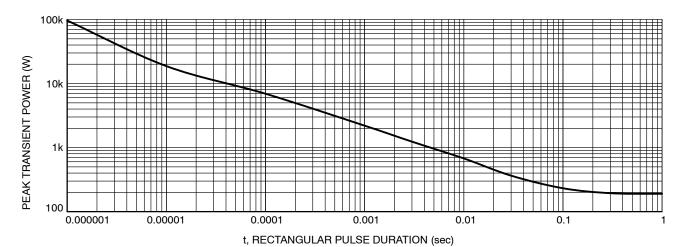
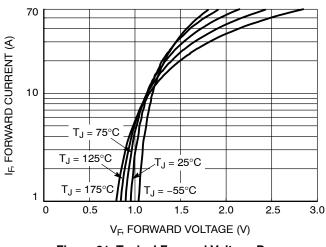


Figure 20. Peak Power

TYPICAL CHARACTERISTICS - DIODES



10 (Y) 11 11 125°C T_J = 175°C T_J = 25°C T_J = 75°C T_J = 75°C

Figure 21. Typical Forward Voltage Drop vs. Forward Current

Figure 22. Typical Reverse Current vs.
Reverse Voltage

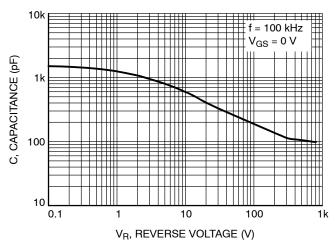


Figure 23. Capacitance

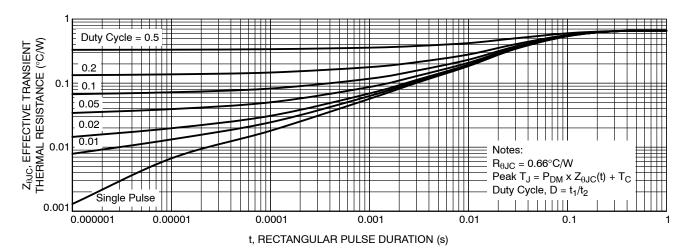
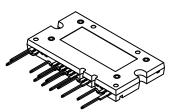


Figure 24. Transient Thermal Impedance

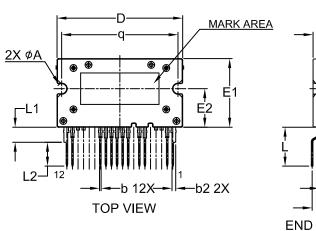


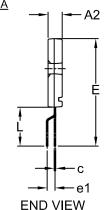


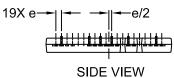
APMCD-A16 / 12LD, AUTOMOTIVE MODULE

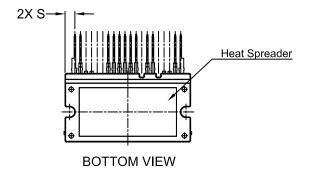
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NOTES:

- 1. DIMENSIONING AND TOLERANCING PER. ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION: MILLIMETERS
- DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR EXTRUSIONS.

| | MILLIMETERS | | | | |
|-----|-------------|-----------|-------|--|--|
| DIM | MIN. | NOM. | MAX. | | |
| A2 | 4.30 | 4.50 | 4.70 | | |
| b | 0.45 | 0.50 | 0.60 | | |
| b2 | 1.15 | 1.20 | 1.30 | | |
| С | 0.45 | 0.50 | 0.60 | | |
| D | 39.90 | 40.10 | 40.30 | | |
| Е | 33.80 | 34.30 | 34.80 | | |
| E1 | 21.70 | 21.90 | 22.10 | | |
| E2 | 12.10 | 12.30 | 12.50 | | |
| е | 1.478 | 1.778 | 2.078 | | |
| e1 | 2.20 | 2.50 | 2.80 | | |
| L | 12.10 | 12.40 | 12.70 | | |
| L1 | | 4.80 REF | | | |
| L2 | 7.30 | 7.60 | 7.90 | | |
| q | 36.85 | 37.10 | 37.35 | | |
| S | | 3.159 REF | | | |
| ØΑ | 3.00 | 3.20 | 3.40 | | |

GENERIC MARKING DIAGRAM*

XXXX = Specific Device Code

ZZZ = Lot ID

AT = Assembly & Test Location

Y = Year WW = Work Week

NNN = Serial Number

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

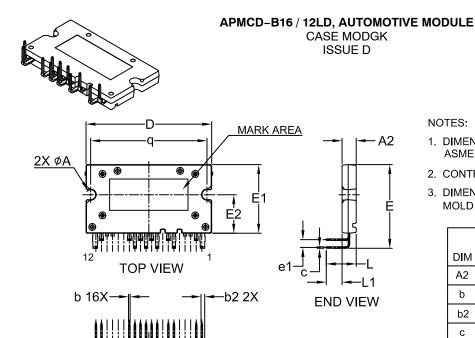
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| DESCRIPTION: | APMCD-A16 / 12LD, AUTOMOTIVE MODULE | | PAGE 1 OF 1 | |

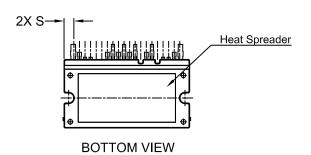
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DATE 04 NOV 2021



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SIDE VIEW

NOTES:

- 1. DIMENSIONING AND TOLERANCING PER. ASME Y14.5M, 2009.
- 2. CONTROLLING DIMENSION; MILLIMETERS
- 3. DIMENSIONS ARE EXCLUSIVE OF BURRS, MOLD FLASH AND TIE BAR EXTRUSIONS.

| | MILLIMETERS | | |
|-----|-------------|-------|-------|
| DIM | MIN. | NOM. | MAX. |
| A2 | 4.30 | 4.50 | 4.70 |
| b | 0.45 | 0.50 | 0.60 |
| b2 | 1.15 | 1.20 | 1.30 |
| С | 0.45 | 0.50 | 0.60 |
| D | 39.90 | 40.10 | 40.30 |
| E | 26.20 | 26.70 | 27.20 |
| E1 | 21.70 | 21.90 | 22.10 |
| E2 | 12.10 | 12.30 | 12.50 |
| е | 1.478 | 1.778 | 2.078 |
| e1 | 2.20 | 2.50 | 2.80 |
| L | 9.20 | 9.55 | 9.90 |
| L1 | 4.70 | 5.05 | 5.40 |
| q | 36.85 | 37.10 | 37.35 |
| S | 3.159 REF | | |
| ΦA | 3.00 | 3.20 | 3.40 |

GENERIC MARKING DIAGRAM*

XXXXXXXXXXXXXXX **777 ATYWW** NNNNNN

XXXX = Specific Device Code

ZZZ = Lot ID

ΑT = Assembly & Test Location

Υ = Year W = Work Week

NNN = Serial Number

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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| DESCRIPTION: APMCD-B16 / 12LD, AUTOMOTIVE MODULE | | PAGE 1 OF 1 | |

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